Search Notes (continued)



Application/Control No.		
10/617.076		

Applicant(s)/Patent under Reexamination TANAKA, GENICHI Art Unit

Examiner Sun J. Lin

2825

SEARCHED					
Class	Subclass	Date	Examiner		
716	6	6/13/2006	JSL		
716	7	6/13/2006	JSL		
716	4	6/13/2006	JSL		
716	5	6/13/2006	JSL		
		:			

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
716	6	6/13/2006	JSL		
716	7	6/13/2006	JSL		
716	4,5	6/13/2006	JSL		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST [USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB]	6/13/2006	JSL	